## Application/Control No. .Applicant(s)/Patent Under Reexamination 10/699,648 ISHIKAWA, NAOYA Notice of References Cited Art Unit Examiner Page 1 of 1 3748 Thai-Ba Trieu **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY Α US-В US-C US-US-D Ε US-US-F US-G US-Н USı J US-Κ US-L US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY 10-1995 TSUCHIYA et al. F01N 03/02 Ν JP 07259654 A Japan YANAGISAWA, NAOKI F01N 03/02 0 JP 2002285879 A 10-2002 Japan Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

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